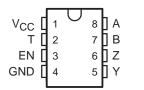
SN75177B, SN75178B DIFFERENTIAL BUS REPEATERS

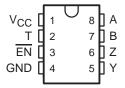
SLLS002C - D2606, JULY 1985 - REVISED FEBRUARY 1993

- Meets EIA Standards RS-422-A and RS-485 and CCITT Recommendations V.11 and X.27
- Designed for Multipoint Transmission on Long Bus Lines in Noisy Environments
- 3-State Outputs
- Bus Voltage Range . . . −7 V to 12 V
- Positive and Negative Current Limiting
- Driver Output Capability . . . 60 mA Max
- Driver Thermal Shutdown Protection
- Receiver Input Impedance . . . 12 k Ω Min
- Receiver Input Sensitivity . . . ±200 mV
- Receiver Input Hysteresis . . . 50 mV Typ
- Operates From Single 5-V Supply
- Low Power Requirements

SN75177B . . . D OR P PACKAGE (TOP VIEW)



SN75178B . . . P PACKAGE (TOP VIEW)



THE SN75177B IS NOT RECOMMENDED FOR NEW DESIGN

description

The SN75177B and SN75178B differential bus repeaters are monolithic integrated devices each designed for one-way data communication on multipoint bus transmission lines. These devices are designed for balanced transmission bus line applications and meet EIA Standard RS-422-A and RS-485 and CCITT Recommendations V.11 and X.27. Each device is designed to improve the performance of the data communication over long bus lines. The SN75177B and SN75178B are identical except for the complementary enable inputs, which allow the devices to be used in pairs for bidirectional communication.

The SN75177B and SN75178B feature positive- and negative-current limiting 3-state outputs for the receiver and driver. The receiver features high input impedance, input hysteresis for increased noise immunity, and input sensitivity of ± 200 mV over a common-mode input voltage range of -7 V to 12 V. The driver features thermal shutdown for protection from line fault conditions. Thermal shutdown is designed to occur at a junction temperature of approximately 150°C. The driver is designed to drive current loads up to 60 mA maximum.

The SN75177B and SN75178B are designed for optimum performance when used on transmission buses employing the SN75172 and SN75174 differential line drivers, SN75173 and SN75175 differential line receivers, or SN75176B bus transceiver.

Function Tables

SN75177B

DIFFERENTIAL INPUTS	ENABLE	OUTPUTS		
A – B	EN	T	Υ	Z
V _{ID} ≥ 0.2 V	Н	Н	Н	L
$-0.2 \text{ V} < \text{V}_{1D} < 0.2 \text{ V}$	Н	?	?	?
$V_{ID} \le 0.2 V$	н	L	L	Н
Χ	L	Z	Z	Z

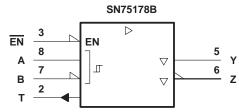
SN75178B

DIFFERENTIAL INPUTS	ENABLE	OUTPUTS		
A – B	EN	Т	Υ	Z
V _{ID} ≥ 0.2 V	L	Н	Н	L
$-0.2 \text{ V} < \text{V}_{\text{ID}} < 0.2 \text{ V}$	L	?	?	?
V _{ID} ≤ 0.2 V	L	L	L	Н
X	Н	Z	Z	Z

H = high level, L = low level, ? = indeterminate, X = irrelevant, Z = impedance (off)

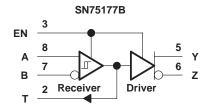


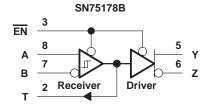
logic symbols†



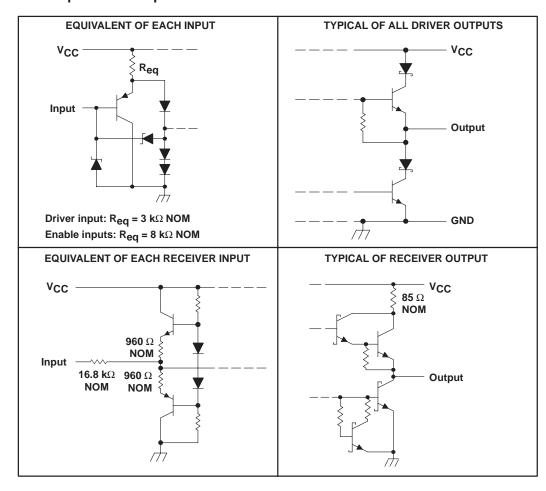
† These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagrams (positive logic)





schematics of inputs and outputs



SN75177B, SN75178B DIFFERENTIAL BUS REPEATERS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC} (see Note 1)	7 V
Voltage range at any bus terminal	10 V to 15 V
Differential input voltage (see Note 2)	±25 V
Enable input voltage	5.5 V
Continuous total dissipation	See Dissipation Rating Table
Operating free-air temperature range	0°C to 70°C
Storage temperature range	65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260∘€

- NOTES: 1. All voltage values, except differential input voltage, are with respect to network ground terminal.
 - 2. Differential input voltage is measured at the noninverting input with respect to the corresponding inverting input.

DISSIPATION RATING TABLE

PACKAGE	$T_{\mbox{\scriptsize A}} \leq 25^{\circ}\mbox{\scriptsize C}$ POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW
Р	1000 mW	8.0 mW/°C	640 mW

recommended operating conditions

		MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}		4.75	5	5.25	V
High-level input voltage, VIH	EN or EN	2			V
low-level input voltage, V _{IL}	EN or EN			0.8	V
Common-mode input voltage, $V_{\mbox{\scriptsize IC}}$	-	_7 [†]		12	V
Differential input voltage, V _{ID}				±12	V
High level cutout current leve	Driver			-60	mA
High-level output current, IOH	Receiver			-400	μΑ
Low level cutout current lev	Driver			60	A
Low-level output current, IOL	Receiver			8	mA
Operating free-air temperature, TA	-	0		70	°C

The algebraic convention, where the less-positive (more-negative) limit is designated minimum, is used in this data sheet for common-mode input voltage and threshold voltage.

DRIVER SECTION

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

	PARAMETER	TEST CO	TEST CONDITIONS		TYP†	MAX	UNIT
VIK	Input clamp voltage	I _I = -18 mA				-1.5	V
VO	Output voltage	I _O = 0		0		6	V
VOD1	Differential output voltage	I _O = 0		1.5		6	V
V _{OD2}	Differential output voltage	$R_L = 100 \Omega$,	See Figure 1	1/2 V _{OD1} or 2§			V
		$R_L = 54 \Omega$,	See Figure 1	1.5	2.5	5	
VOD3	Differential output voltage	See Note 3		1.5		5	V
Δ V _{OD}	Change in magnitude of diferential output voltage [‡]	B 54.0 400.0	Con Figure 4			±0.2	V
Voc	Common-mode output voltage	R _L = 54 \(\overline{12}\) or 100 \(\overline{12}\),	R_L = 54 Ω or 100 Ω , See Figure 1			3 –1	V
Δ VOC	Change in magnitude of common-mode output voltage‡					±0.2	V
lo	Output current	$V_{CC} = 0$,	$V_0 = -7 \text{ V to } 12 \text{ V}$			±100	μΑ
loz	High-impedance-state output current	$V_0 = -7 \text{ V to } 12 \text{ V}$				±100	μΑ
lн	High-level input current	V _I = 2.4 V				20	μΑ
I _Ι L	Low-level input current	V _I = 0.4 V				-400	μΑ
		V _O = -7 V				-250	
los	Short-circuit output current	$V_{O} = V_{CC}$				250	mA
		V _O = 12 V				250	
loo	Supply current (total package)	No load	Outputs enabled		57	70	mA
ICC	Supply culterit (total package)	INO IOAU	Outputs disabled		26	35	IIIA

NOTE 3: See Figure 3.5 of EIA Standard RS-485.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
^t dD	Differential-output delay time	$R_1 = 54 \Omega$	See Figure 3		15	20	ns
t _{tD}	Differential-output transition time	KL = 54 12,	See Figure 3		20	30	ns
^t PZH	Output enable time to high level	$R_L = 110 \Omega$,	See Figure 4		85	120	ns
tPZL	Output enable time to low level	R _L = 110 Ω,	See Figure 5		40	60	ns
tPHZ	Output disable time from high level	$R_L = 110 \Omega$,	See Figure 4		150	250	ns
tPLZ	Output disable time from low level	R _L = 110 Ω,	See Figure 5		20	30	ns

[†] All typical values are at V_{CC} = 5 V and T_A = 25°C. ‡ $\Delta |V_{OD}|$ and $\Delta |V_{OC}|$ are the changes in magnitude of V_{OD} and V_{OC} , respectively, that occur when the input is changed from a high level to a low

 $[\]$ The minimum VOD2 with a 100- Ω load is either 1/2 VOD1 or 2, whichever is greater.

SN75177B, SN75178B DIFFERENTIAL BUS REPEATERS

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SYMBOL EQUIVALENTS

DATA SHEET PARAMETER	RS-422-A	RS-485
Vo	V _{oa,} V _{ob}	V _{oa,} V _{ob}
IVOD1I	Vo	Vo
V _{OD2}	$V_t (R_L = 100 \Omega)$	$V_t (R_L = 54 \Omega)$
IV _{OD3} I		V _t (Test Termination) Measurement 2)
Δ V _{OD}	$ V_t - \overline{V}_t $	$ V_t - \overline{V}_t $
Voc	V _{OS}	Vos
Δ VOC	VOS - VOS	Vos-Vos
los	I _{sa} , I _{sb}	
IO	I _{xa} , I _{xb}	l _{ia} ,l _{ib}

RECEIVER SECTION

electrical characteristics over recommended ranges of common-mode input voltage, supply voltage, and operating free-air temperature (unless otherwise noted)

	PARAMETER	TEST CON	DITIONS	MIN	TYP [†]	MAX	UNIT
V _{T+}	Positive-going input threshold voltage	$V_0 = 2.7 V$,	$I_{O} = -0.4 \text{ mA}$			0.2	V
V _T _	Negative-going input threshold voltage	$V_0 = 0.5 V$,	I _O = 8 mA	-0.2‡			V
V _{hys}	Input hysteresis (V _{T+} – V _T –)				50		mV
VIK	Input clamp voltage at EN	$I_{I} = -18 \text{ mA}$				-1.5	V
Vон	High-level output voltage	V _{ID} = 200 mV, See Figure 2	$I_{OH} = -400 \mu A,$	2.7			V
VOL	Low-level output voltage	$V_{ID} = -200 \text{ mV},$ See Figure 2	I _{OL} = 8 mA,			0.45	V
	High increases that autout account	V- 04V/-04V/				20	4
loz	High-impedance-state output current	V _O = 0.4 V to 2.4 V				-400	μΑ
	Line import comment	Other input at 0 V,	V _I = 12 V			1	A
1	Line input current	See Note 4	V _I = -7 V			-0.8	mA
ΊΗ	High-level enable-input current	V _{IH} = 2.7 V				20	μΑ
Ι _{ΙL}	Low-level enable-input current	V _{IL} = 0.4 V				-200	μΑ
rį	Input resistance			12			kΩ
los	Short-circuit output current			-15		-85	mA
loo	Supply current (total package)	No load	Outputs enabled		57	70	mA
Icc	Supply culterit (total package)	INO IOAU	Outputs disabled		26	35	IIIA

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

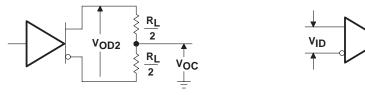
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
^t PLH	Propagation delay time, low-to-high level output	$V_{ID} = -1.5 \text{ V to } 1.5 \text{ V},$		19	35	ns
tPHL	Propagation delay time, high-to-low level output	C _L = 15 pF, See Figure 6		30	40	115
^t PZH	Output enable time to high level	C _I = 15 pF, See Figure 7		10	20	nc
tPZL	Output enable time to high level	OL = 15 pr, See rigule /		12	20	ns
t _{PHZ}	Output disable time from high level	C _I = 15 pF, See Figure 8		25	35	no
t _{PLZ}	Output disable time from low level	CL = 15 pr, See rigure 6		17	25	ns



[‡] The algebraic convention, where the less-positive (more-negative) limit is designated minimum, is used in this data sheet for common-mode input voltage and threshold voltage levels only.

NOTE 4: Refer to EIA Standard RS-422 for exact conditions.

PARAMETER MEASUREMENT INFORMATION



V_{ID} V_{OH} V_{OH}

Figure 1. Driver $V_{\mbox{\scriptsize OD}}$ and $V_{\mbox{\scriptsize OC}}$

Figure 2. Receiver VOH and VOL

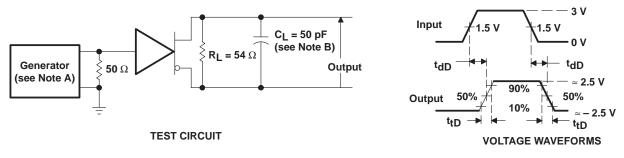


Figure 3. Driver Differential-Output Test Circuit and Voltage Waveforms

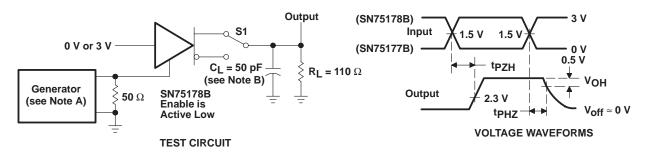


Figure 4. Driver Enable and Disable Times

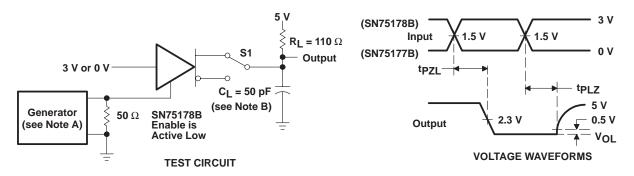


Figure 5. Driver Enable and Disable Times

NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, $t_{\text{f}} \leq$ 6 ns, $t_{\text{f}} \leq$ 7 ns, $t_{\text{f}} \leq$ 8 ns, $t_{\text{f}} \leq$ 9 ns, $t_{$

B. C_L includes probe and jig capacitance.



PARAMETER MEASUREMENT INFORMATION

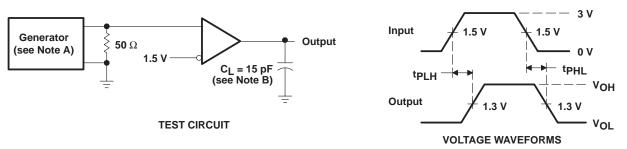


Figure 6. Receiver Propagation Delay Times

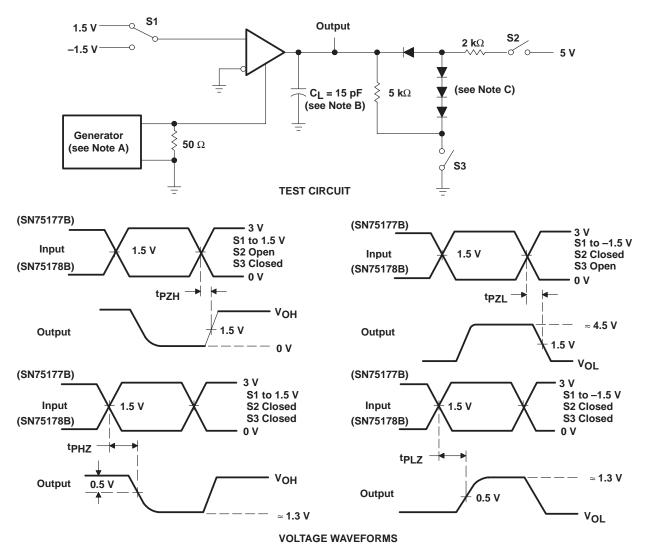


Figure 7. Receiver Output Enable and Disable Times

- NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, $t_{\text{f}} \leq$ 6 ns, $t_{\text{f}} \leq$ 7 ns, $t_{\text{f}} \leq$ 8 ns, $t_{\text{f}} \leq$ 9 ns, $t_{$
 - B. CL includes probe and jig capacitance.
 - C. All diodes are 1N916 or equivalent.



TYPICAL CHARACTERISTICS

DRIVER HIGH-LEVEL OUTPUT VOLTAGE

vs HIGH-LEVEL OUTPUT CURRENT

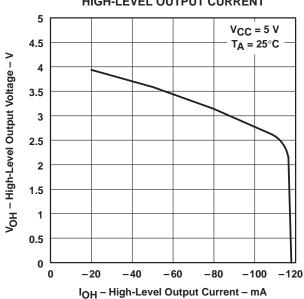


Figure 8

IOH – High-Level Ot

DRIVER DIFFERENTIAL OUTPUT VOLTAGE vs

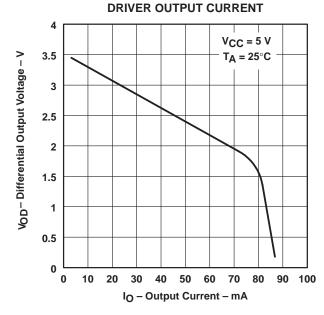


Figure 10

DRIVER LOW-LEVEL OUTPUT VOLTAGE vs

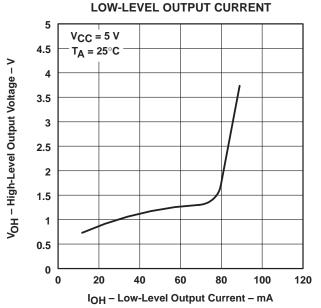


Figure 9

RECEIVER OUTPUT VOLTAGE vs

vs DIFFERENTIAL INPUT VOLTAGE

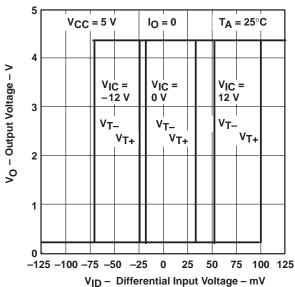


Figure 11

TYPICAL CHARACTERISTICS

RECEIVER HIGH-LEVEL OUTPUT VOLTAGE

HIGH-LEVEL OUTPUT CURRENT

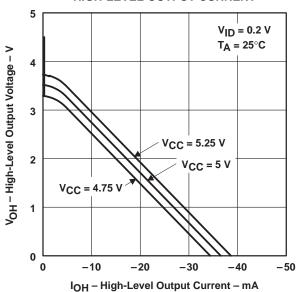


Figure 12

FREE-AIR TEMPERATURE 5

RECEIVER HIGH-LEVEL OUTPUT VOLTAGE vs

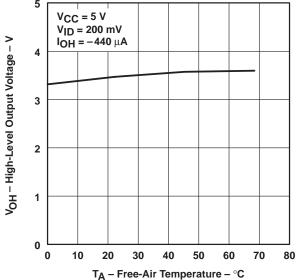


Figure 13

RECEIVER LOW-LEVEL OUTPUT VOLTAGE

LOW-LEVEL OUTPUT CURRENT

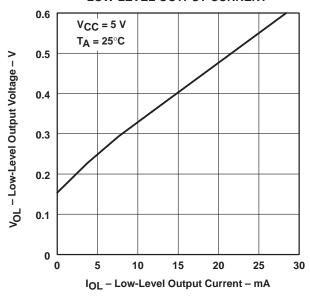


Figure 14

RECEIVER LOW-LEVEL OUTPUT VOLTAGE

٧S FREE-AIR TEMPERATURE

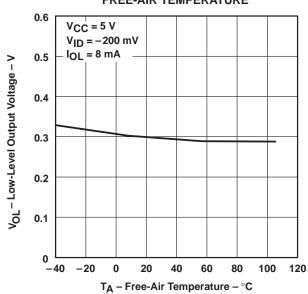
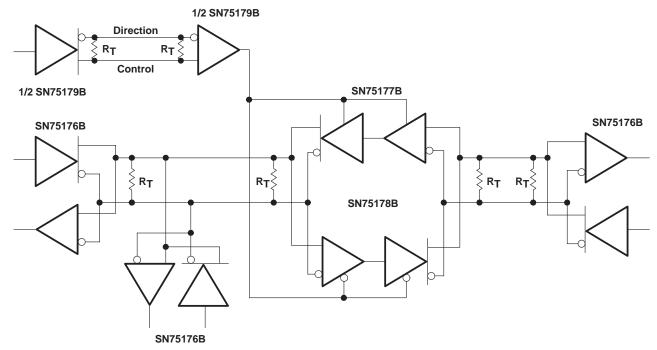


Figure 15

APPLICATION INFORMATION



NOTE: The line should be terminated at both ends in its characteristic impedance. Stub lengths off the main line should be kept as short as possible.

Figure 16. Typical Application Circuit

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